Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/825,339	SHIRAHATA ET AL.		
Examiner	Art Unit		
TUYEN T. NGUYEN	2832		

	SEAR	CHED	
Class	Subclass	Date	Examiner
336	57, 58, 60, 61, 69, 210-213,	7/19/2005	TTN
336	216, 233	7/19/2005	TTN
336	234	7/19/2005	TTN
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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